Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10577445	KONDO ET AL.
Examiner	Art Unit
SHEELA CHAWAN	2624

SEARCHED						
Class	Subclass	Date	Examiner			
428	116,180,188,117,118,34.4	2/16/09	SCC			
52	239,523,dig30,523	""	II .			
502	439,527.18,527.19,527.21	"	"			
425	461,467,380,465,464	"	"			
422	174,180,222,177,211	"	II .			
296	39.1	"	II .			
356	71	"	"			
382	141, 224, 145, 151, 149, 304,	"	II .			

SEARCH NOTES		
Search Notes	Date	Examiner
SEARCH EAST AND OTHER DATA BASE, East (see search history printout)	6/9/08	ahm

	INTERFERENCE SEAR	СН	
Class	Subclass	Date	Examiner

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